



PATENT APPLICATION *crh*

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Re the Application of

Izumi FUSEGAWA et al.

Application No.: 10/510,695

Filed: October 8, 2004

Docket No.: 121356

For: METHOD OF MANUFACTURING SILICON SINGLE CRYSTAL, SILICON SINGLE CRYSTAL AND SILICON WAFER

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- 3. Reference 3 corresponds to reference 4.

Respectfully submitted,

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WPB:RBI/crh

Date: April 6, 2006

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Sheet 1 of 1

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 121356	APPLICATION NO. 10/510,695	
INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)		APPLICANTS Izumi FUSEGAWA et al.				
		FILING DATE October 8, 2004				
U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number	Date	Name		
	1	6,197,108	03/06/2001	IINO et al.		
	2	5,911,823	06/15/1999	SONODA et al.		
	3	5,911,822	06/15/1999	ABE et al.		
FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
	4	CN 1193054 A	09/16/1998	CHINA		
OTHER DOCUMENTS						
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)				
EXAMINER					DATE CONSIDERED	
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						

Date: April 6, 2006